

Intermittent Fault Detector (IFD-256™)

- Total Air Temperature (TAT) Probes

IFD-256 Test Summary



Prepared and Submitted by:

Universal Synaptics 4066 S 1900 W Ste B Roy, Utah 84067 801.731.8508

10 July 2019

COMMERCIAL-IN-CONFIDENCE

Universal Synaptics Corporation (USC) owns the copyright in this document. It cannot be used for any purpose other than that for which it is supplied nor reproduced or copied, in whole or in part. It is Commercial-in-Confidence and is not to be communicated to any person without written consent from USC.



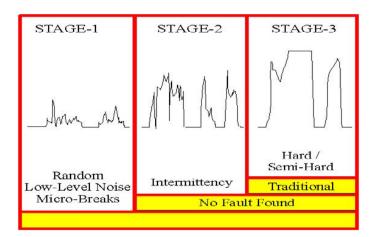
Total Air Temperature (TAT) Probes (P/Ns 102LA2AG, 102LJ2AG) S/Ns: A80547, A29936

Introduction:

The subject **Total Air Temperature (TAT)** Probes were tested at the request of **for the purpose of demonstrating the advanced diagnostic capability of the** Intermittent Fault Detector[™] (IFD[™]). Universal Synaptics received the TAT Probes on 28 June 2019, testing began on 2 July 2019 using the portable Intermittent Fault Detector (IFD-256[™]). The Interface Test Adaptor (ITA) was designed and manufactured by Universal Synaptics for this test project.

Test Procedures:

- AutoMap[™] discovered the UUT true as-wired configuration (No OEM data/schematics required if "Gold" units are provided; OEM data was used for building correct baseline map due to both TAT Probes being in non-working condition)
- 1. Continuity tests for open circuits
- 2. Shorts provides shorts indication and shorts tracing
- 3. Intermittence monitors all circuits to detect and isolate *all three Stages* of intermittent faults (see Graphic 1)



<u>Stage 1</u> – random low-level nanosecond microbreaks, likely not operationally evident yet, but on curve of degradation to become Stage 2

<u>Stage 2</u> – intermittent failure evident to pilot in operation, reported to ground crew, passes ground test and labeled No Trouble Found (NTF) or No Fault Found (NFF). On curve of degradation to become Stage 3

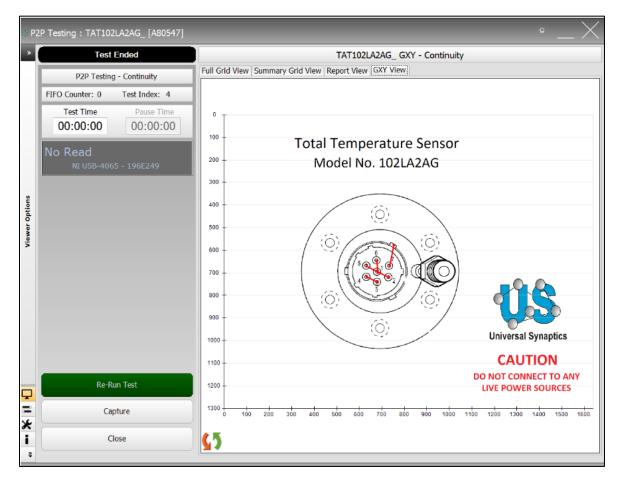
<u>Stage 3</u> – semi-hard or hard failures, Automatic Test Equipment (ATE) and troubleshooting tools such as DMMs designed to detect hard faults (open circuits or shorted circuits)

Graphic 1 – Three Stages of an Intermittent Fault



S/N: A80547

- 1. IFD-256 Continuity testing conducted test points 4, 5, 6, and shield (TP#8) were outside ohmic measurement tolerances (see Graphics 2 and 3)
- 2. IFD-256 Shorts testing conducted shorted circuits were detected on test points 3 and 7 and traced back to test point 2 (see Graphics 4 and 5)
- 3. IFD-256 Intermittence testing conducted 2 intermittent events detected on test point 4 and 3 intermittent events detected on test point 6 (see Graphics 6, 7, and 8)

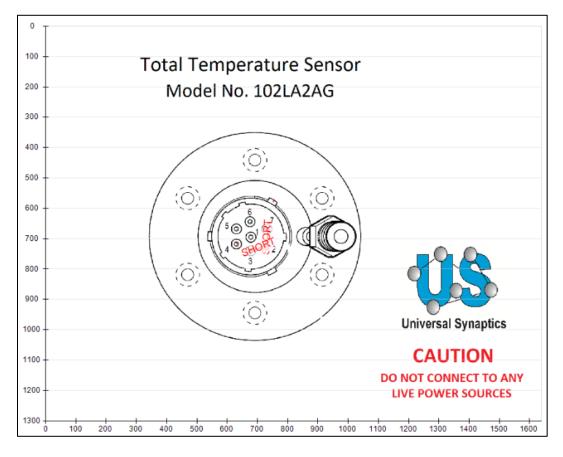


Graphic 2 - Continuity Graphic (GXY View) - S/N: A80547



-										
1	Results Re	port H	eader for	r - Continu	uity Tea	st				
i -	Test Infor	mation	:							
ļ.	Unit b	eing t	ested			TAT10	2LA2AG_			
i -	Unit s	erial	number .			A8054	17			
i -	Date t	ested	(yyyy-mm-	-dd)		2019-	-07-02			
	Time t	ested				13:25	:46			
	Operat	or				User	Administat	or		
I										
A8054	47 SUMMARY	OF NOD	AL CONTIN	WITY TEST	RESULTS	S FOR: 1	AT102LA2AG	_		
TP#				MEAS (DIFF)						
6	TP-06	1	22.00	46.76 (24	.76)	CON-Def	ault FAIL	@TP-01		
5	TP-05	2	500.00	23.31 (47)	6.69)	CON-Def	ault FAIL	@TP-02		
4	TP-04	3	500.00	23.37 (47)	6.63)	CON-Def	ault FAIL	@TP-03		
8	TP-08	4	0.010	18.54 (18	.53)	CON-Def	ault FAIL	@TP-07		
	inuity Test									
FULL	NODAL CONT	INUITY	TEST RES	SULTS FOR:	TAT102	LA2AG_				
TP#	NOMEN	NODE	TOLERAN	CE METHOD	GOLD	MEAS ((DIFF)	DIAGNOSTIC		
6	TP-06	1	+5%-5%	OneRead	22	46.76	(24.76)	CON-Default	FAIL	@TP-01
								CON-Default		
4	TP-04	3	+5%-5%	OneRead	500	23.37	(476.63)	CON-Default	FAIL	@TP-03
8	TP-08	4	+5%-5%	OneRead	0.01	18.54	(18.53)	CON-Default	FAIL	@TP-07

Graphic 3 - Continuity Report & Results (Report View) - S/N: A80547

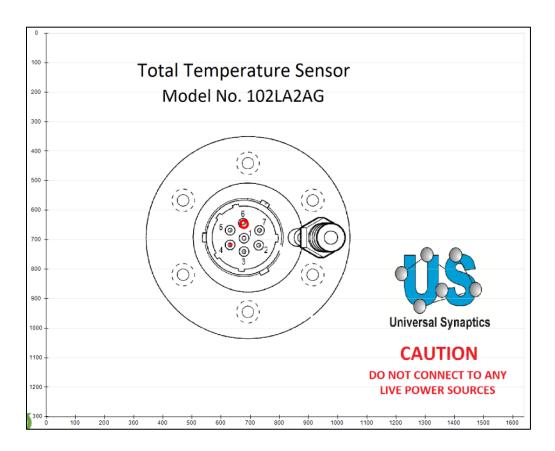


Graphic 4 - Shorts Graphic - S/N: A80547



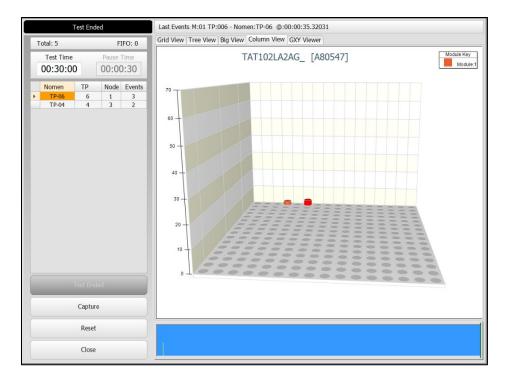
]	Results Report Header for - Trace Test	
i	*	i.
1 1	Test Information:	1
I		1
	Unit being tested	TAT102LA2AG_
 	Unit serial number	A80547
1		1
1	Date tested (yyyy-mm-dd)	2019-07-02
	Time tested	13:22:16
1		
1	Operator	User Administator
I		
	7 SUMMARY OF TRACE TEST RESULTS FOR: TAT102	-
	from TP-03 node:3 traced to TP-02 node:2 b	-
Short	from TP-07 node:4 traced to TP-02 node:2 b	y 23.150hms

Graphic 5 - Shorts Report & Results - S/N: A80547

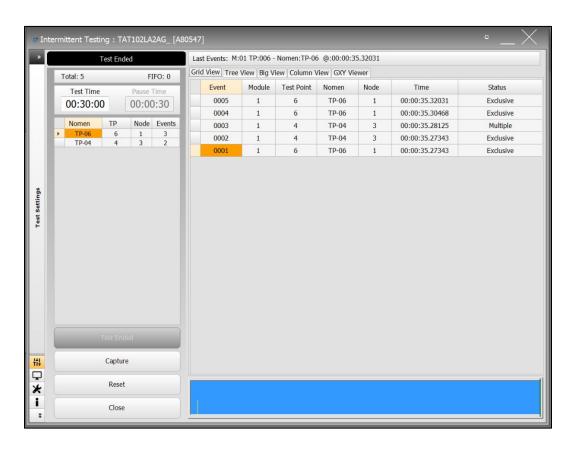


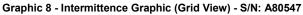
Graphic 6 - Intermittence Graphic (GXY View) - S/N: A80547





Graphic 7 - Intermittence Graphic (Column View) - S/N: A80547



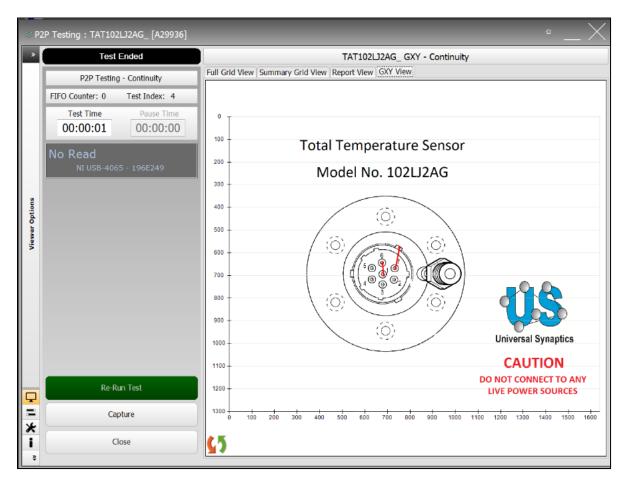


COMMERCIAL-IN-CONFIDENCE



S/N: A29936

- 1. IFD-256 Continuity testing conducted test points 6 and shield (TP#8) read open circuit and outside ohmic measurement tolerances, respectively (see Graphics 9 and 10)
- IFD-256 Shorts testing conducted no shorted circuits were detected on this UUT (see Graphics 11 and 12)
- IFD-256 Intermittence testing conducted 4 intermittent events detected on shield (TP#8) (see Graphics 13 and 14)

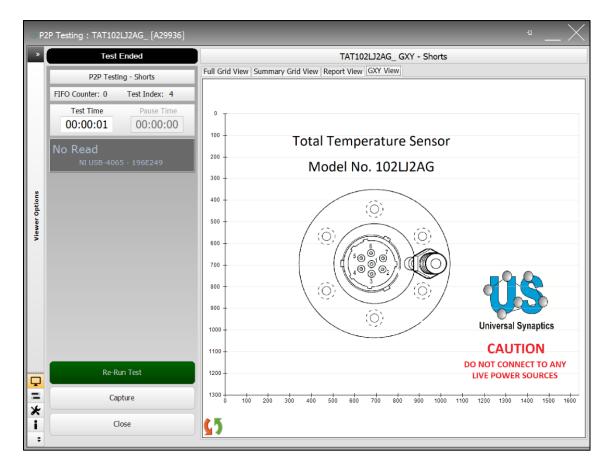


Graphic 9 - Continuity Graphic (GXY View) - S/N: A29936



P2	2P Testing : TAT102	2LJ2AG_ [A29936]								$- \times$
* Test Ended			Test Report - Continuity							
	P2P Testing - Continuity		Full Grid View Summary Grid View Report View GXY View							
	FIFO Counter: 0	Test Index: 4	Resul	ts Report 1	Header for	- Continuity	Test			ŕ
	Test Time	Pause Time	Test	Informatio	n:					
	00:00:01	00:00:00	i u	nit being	tested		. TAT102LJ2AG_		i i	
	No Read		1 U	nit serial	number		. A29936		l.	
		5 - 196E249	D	ate tested	(УУУУ-mm-0	dd)	. 2019-07-02		-	
			T	ime tested			. 13:37:36			
s			C	perator	•••••		. User Administ	tator		
Viewer Options			TP# NOME	N NODE 6 1 8 4	GOLD 1 22.00 1 0.010 1	MEAS(DIFF) POC (>100) 18.12 (18.11)	LTS FOR: TAT102LJ2 DIAGNOSTIC CON-Default FOO CON-Default FAI	C-FAIL @TP-01		
			FULL NODAL TP# NOME			ULTS FOR: TAT1		DINGNOSTIC		
			6 TP-0 01		+5%-5%	E METHOD GOLD OneRead 22		DIAGNOSTIC CON-Default	POC-FAIL	@TP-
			5 TP-0 4 TP-0 8 TP-0	4 3	+5%-5% +5%-5% +5%-5%		38 567.59 (0.21) 47 567.68 (0.21) 18.12 (18.11)		PASS OTP-	03

Graphic 10 - Continuity Report & Results (Report View) - S/N: A29936

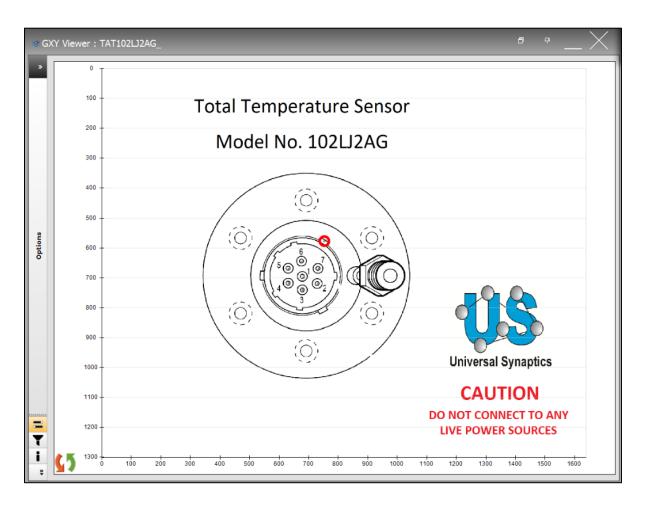


Graphic 11 - Shorts Graphic (GXY View) - S/N: A29936



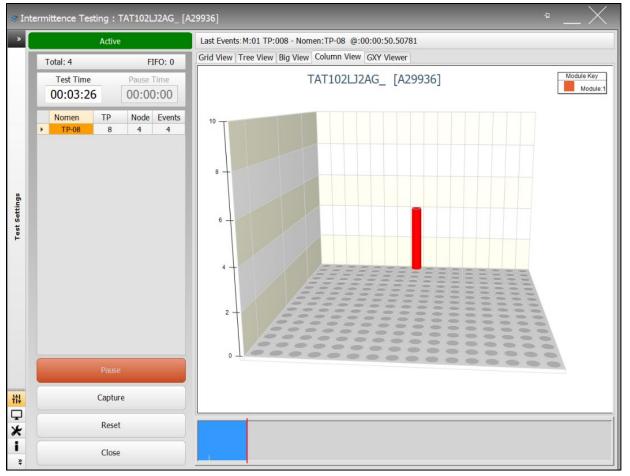
Те	st Ended	Test Report - Shorts				
P2P Te	esting - Shorts	Full Grid View Summary Grid View Report View GXY View				
FIFO Counter: 0	Test Index: 4	Results Report Header for - Shorts Test				
Test Time	Pause Time	Test Information:				
00:00:01	00:00:00	Unit being tested TAT102LJ2AG_				
		Unit serial number A29936				
No Read		Date tested (yyyy-mm-dd) 2019-07-02				
NI USB-4	065 - 196E249	Time tested 13:40:25				
		Operator User Administator				
		A29936 SUMMARY OF NODAL SHORTS TEST RESULTS FOR: TAT102LJ2AG_ TP\$ NOMEN NODE\$ DIAGNOSTIC FOR SHORTS - ORDERED BY NO	DE NUMBER			

Graphic 12 - Shorts Report & Results (Report View) - S/N: A29936



Graphic 13 - Intermittence Graphic (GXY View) - S/N: A29936





Graphic 14 - Intermittence Graphic (Column View) - S/N: A29936



Summary:

Universal Synaptics' patented Intermittent Fault Detection technology has proven to detect and isolate intermittent faults which results in an increase in aircraft component reliability. As proven by this demonstration, the IFD-256 will increase the reliability of the aircraft by ensuring that quality TAT Probes are installed on **aircraft**, subsequently preventing Operational Difficulty Index (ODI) events and customer dissatisfaction.

S/N: A80547

provided details:

- Installed: 12/15/2012
- Removed: 6/9/2019
- Time Since Overhaul (TSO) / Cycles Since Overhaul (CSO): 9,338 FH / 5,061 FC
- No previous removal history
- Believed to be a new probe, not a repaired probe
- > Continuity, Shorts, and Intermittence tests indicate a catastrophic failure of this probe
- Based on the curve of degradation from a Stage 1 (random low-level micro-breaks) to a Stage 2 (intermittent that causes operational failure) to a Stage 3 (semi-hard or hard broke), this asset was a candidate for IFD testing prior to install
 - All Stage 3 continuity and shorts found during testing could have likely been manifesting as Stage 1 faults and repaired prior to install, thus extending time-onwing greater than 9,338 FH

S/N: A29936

provided details:

1st Install

- Installed on A/C #6707: 12/15/2015
- Removed from A/C #6707: 3/22/2017
- Reason for removal: proactive replacement of TAT due to trend shift on both engines
- Unit overhauled by 5/1/2017 (overhauled with latest and greatest Repair Specification)

2nd Install

- Installed on A/C #6717: 6/15/2018
- Removed from A/C #6717: 6/6/2019
- Time Since Overhaul (TSO) / Cycles Since Overhaul (CSO): 3,074 FH / 1,294 FC
- Reason for removal: EICAS message for TAT Probe
- Unit last overhauled: 5/1/2017



- > Continuity and Intermittence tests indicate a catastrophic failure of this probe
- Based on the curve of degradation from a Stage 1 (random low-level micro-breaks) to a Stage 2 (intermittent that causes operational failure) to a Stage 3 (semi-hard or hard broke), this asset was a candidate for IFD testing prior to install
 - All Stage 3 continuity and shorts found during testing could have likely been manifesting as Stage 1 or 2 faults and repaired prior to install, thus extending time-on-wing greater than 3,074 FH



Image 1 – Total Air Temperature Probes – S/N: A80547 and S/N: A29936